Notice of References Cited Application/Control No. 10/605,222 Examiner Tianjie Chen Applicant(s)/Patent Under Reexamination ARMAGOST ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,600,703 B1	07-2003	Emberty et al.	369/30.83
*	В	US-6,845,422 B2	01-2005	Shimada et al.	710/305
*	С	US-6,880,033	04-2005	Mahmoud et al.	710/305
*	D	US-5,442,500 A	08-1995	Hidano et al.	360/92
*	E	US-6,704,832 B1	03-2004	Ng, Yiu-Keung	710/316
*	F	US-6,782,448 B2	08-2004	Goodman et al.	711/112
*	G	US-6,859,854 B2	02-2005	Kwong, Bill	710/315
*	Н	US-6,512,962 B2	01-2003	Dimitri et al.	700/214
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.